


<b>Search Notes</b>  	<b>Application/Control No.</b>  10588480	<b>Applicant(s)/Patent Under Reexamination</b>  YOON ET AL.
	<b>Examiner</b>  QUN SHEN	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
455	452.1, 452.2	2/18/2010	qs
371	329	2/18/2010	qs

SEARCH NOTES		
Search Notes	Date	Examiner
Text search on EAST	2/20/2010	qs
Google patent search	2/17/2010	qs
International search report	2/17/2010	qs
inventor search	2/17/2010	qs

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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